

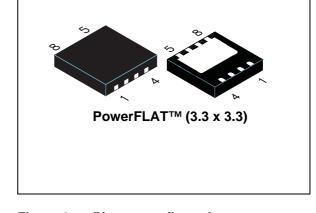
STL17N3LLH6

N-channel 30 V, 0.0038 Ω 17 A PowerFLATTM(3.3x3.3) STripFET™ VI DeepGATE™ Power MOSFET

Features

Order code	V _{DSS}	R _{DS(on)} max.	I _D
STL17N3LLH6	30 V	$0.0045~\Omega$	17 A ⁽¹⁾

- 1. The value is rated according R_{thi-pcb}
- R_{DS(on)} * Q_q industry benchmark
- Extremely low on-resistance R_{DS(on)}
- High avalanche ruggedness
- Low gate drive power losses
- Very low switching gate charge



Application

Switching applications

Description

This product utilizes the 6th generation of design rules of ST's proprietary STripFET™ technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest R_{DS(on)} in a standard package, that makes it suitable for the most demanding DC-DC converter applications, where high power density has to be achieved.

Figure 1. Pin-out configuration

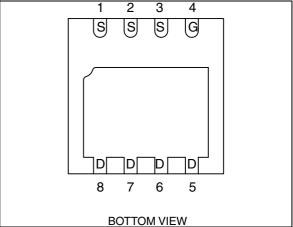


Table 1. **Device summary**

Order code	Marking	Package	Packaging
STL17N3LLH6 17N3L		PowerFLAT™ (3.3 x 3.3)	Tape and reel

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STL17N3LLH6 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	30	V
V _{GS}	Gate-source voltage	± 20	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	17	Α
I _D ⁽¹⁾	Drain current (continuous) at T _C = 100 °C	11	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	68	Α
P _{TOT} (3)	Total dissipation at T _C = 25 °C	50	W
P _{TOT} ⁽¹⁾	Total dissipation at T _C = 25 °C	2	W
	Derating factor	0.03	W/°C
T _J T _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

- 1. The value is rated according $R_{\mbox{\scriptsize thj-pcb}}$
- 2. Pulse width limited by safe operating area
- 3. The value is rated according R_{thj-c}

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case (drain) (steady state)	2.5	°C/W
R _{thj-pcb} (1)	Thermal resistance junction-pcb	42.8	°C/W
R _{thj-pcb} ⁽²⁾	Thermal resistance junction-pcb	63.5	°C/W

- 1. When mounted on FR-4 board of 1inch 2 , 2oz Cu, t < 10 sec
- 2. Steady state

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0$	30			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = Max rating, V_{DS} = Max rating @ 125 °C			1 10	μ Α μ Α
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±20 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1			V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 8.5 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 8.5 \text{ A}$		0.0038 0.0057	0.0045 0.0073	Ω Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f=1 MHz,}$ $V_{GS} = 0$	-	1690 290 176	-	pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} = 15 V, I_D = 17 A V_{GS} = 4.5 V (see Figure 14)	-	17 8 6	-	nC nC nC
R _G	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20 mV open drain	1	1.7	-	Ω

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 15V, I_{D} = 8.5A,$ $R_{G} = 4.7\Omega, V_{GS} = 10V$ (see Figure 13)	-	9.5 30 37 12	-	ns ns ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		17	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		68	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 17 A, V _{GS} = 0	-		1.1	V
t _{rr}	Reverse recovery time	I _{SD} = 17 A,		24		ns
Q_{rr}	Reverse recovery charge	di/dt = 100 A/μs,	-	16.8		nC
I _{RRM}	Reverse recovery current	V _{DD} = 25 V		1.4		Α

^{1.} Pulse width limited by safe operating area.

^{2.} Pulsed: pulse duration=300 μ s, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

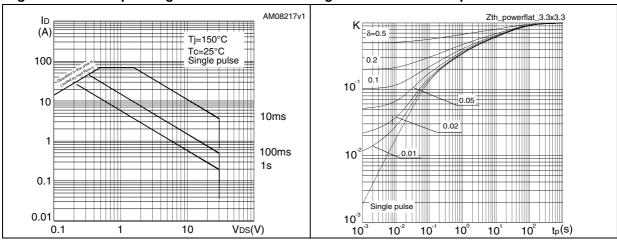


Figure 4. Output characteristics

Figure 5. Transfer characteristics

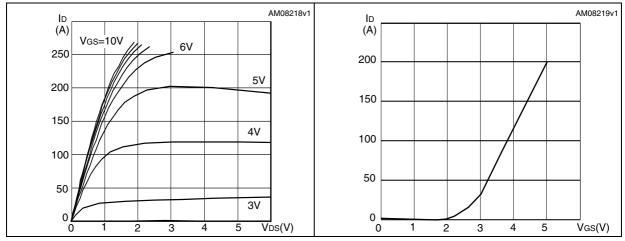
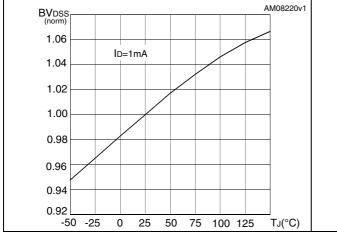
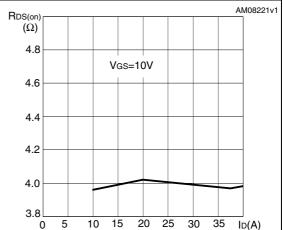


Figure 6. Normalized B_{VDSS} vs temperature Figure 7. Static drain-source on resistance





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AM08222v1 AM08223v1 Vgs (V) (pF) VDD=15V 12 2500 ID=17A 10 2000 Ciss 1500 1000 Coss 500 Crss 0 20 30 40 50 Qg(nC) 10 20 V_{DS}(V) 10

Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage Figure 11. Normalized on resistance vs vs temperature temperature

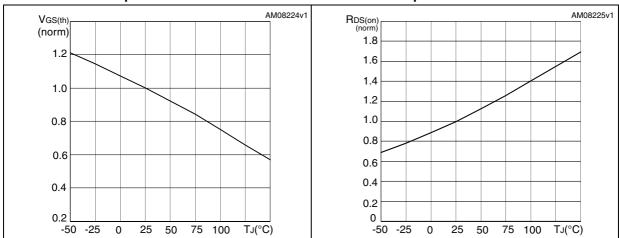
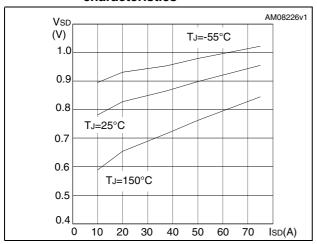


Figure 12. Source-drain diode forward characteristics



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Test circuits STL17N3LLH6

3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

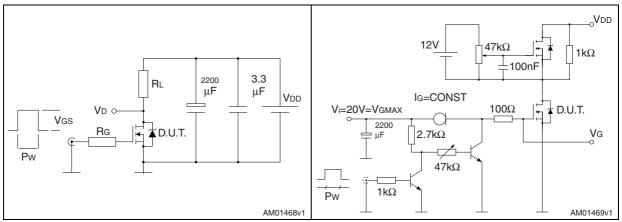


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

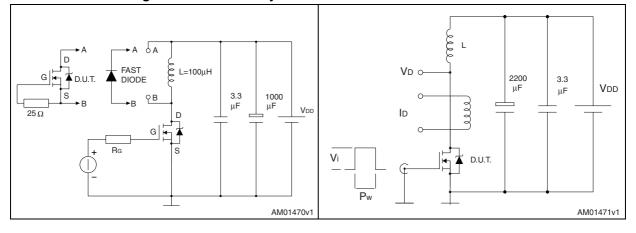
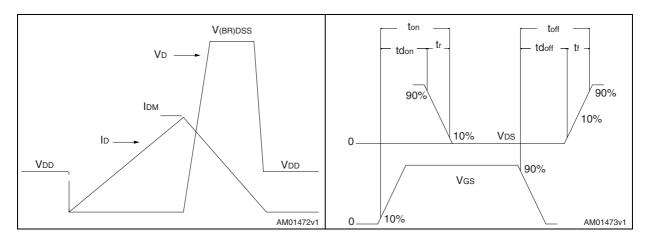


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



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4 Package mechanical data

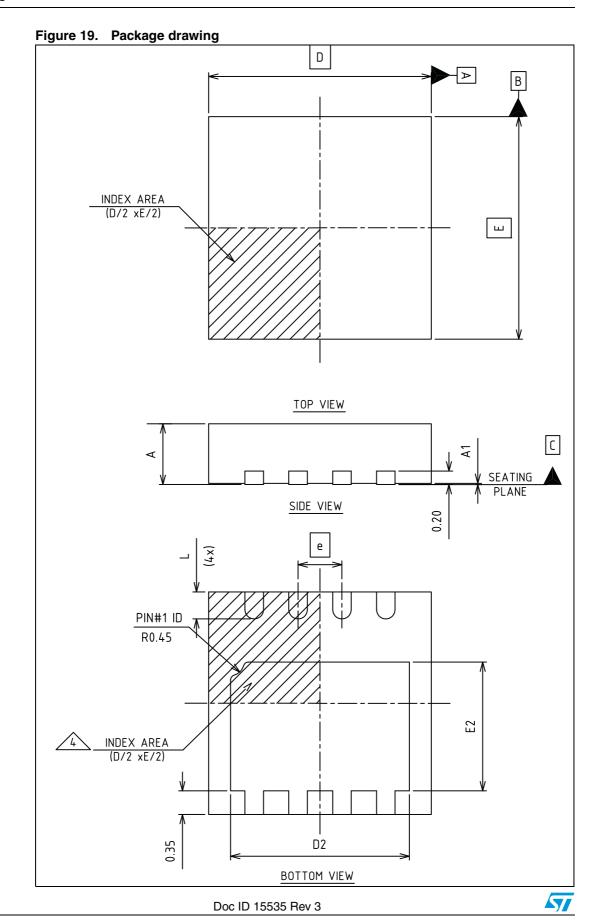
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 8. Package dimensions

Dim.		mm.	
Dilli.	Min.	Тур	Max.
А	0.80	0.90	1.00
A1		0.02	0.05
b	0.25	0.30	0.35
D		3.30	
D2	2.50	2.65	2.75
е		0.65	
Е		3.30	
E2	1.76	1.91	2.01
L	0.30	0.40	0.50

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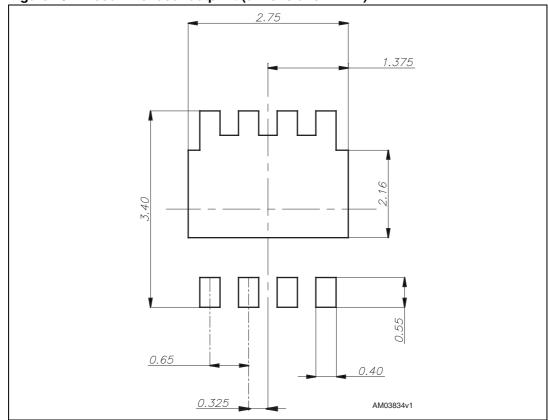


Figure 20. Recommended footprint (dimensions in mm)

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Revision history STL17N3LLH6

5 Revision history

Table 9. Document revision history

Date	Revision	Changes
24-Mar-2009	1	First release.
06-Jul-2010	2	Updated Table 4: On/off states.
10-Nov-2010	3	Document status promoted from preliminary data to datasheet.

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